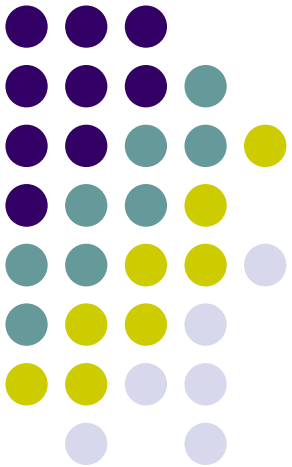
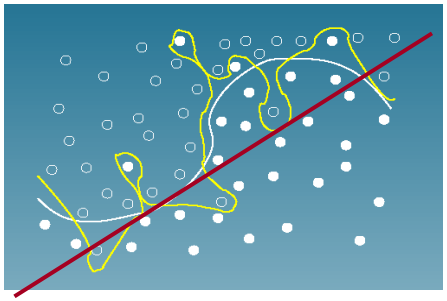
Machine Learning

10-701, Fall 2016

Overfitting and Model Selection



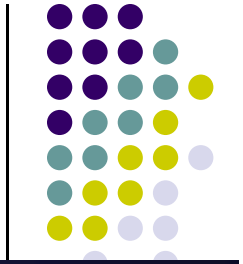
Eric Xing



Lecture 11, October 12, 2016

Reading:

Outline

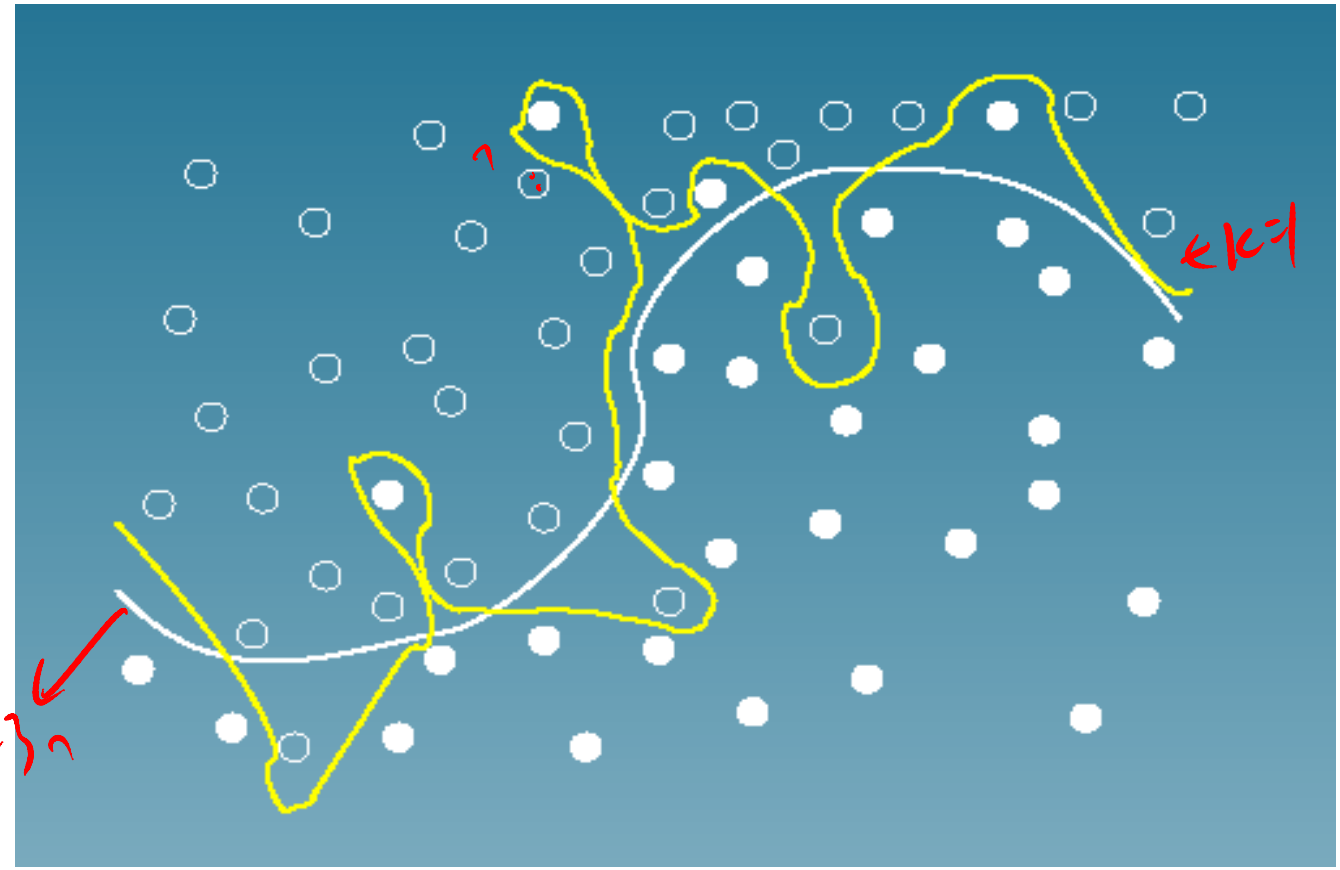


- Overfitting
  - kNN
  - Regression
- Bias-variance decomposition
- Generalization Theory and Structural Risk Minimization
- The battle against overfitting:

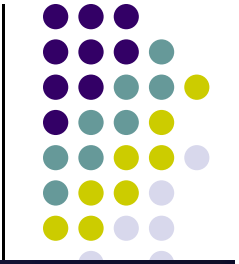
  each learning algorithm has some "free knobs" that one can "tune" (i.e., heck) to make the algorithm generalizes better to test data.

  But is there a more principled way?
  - Cross validation
  - Regularization
  - Feature selection
  - Model selection --- Occam's razor
  - Model averaging

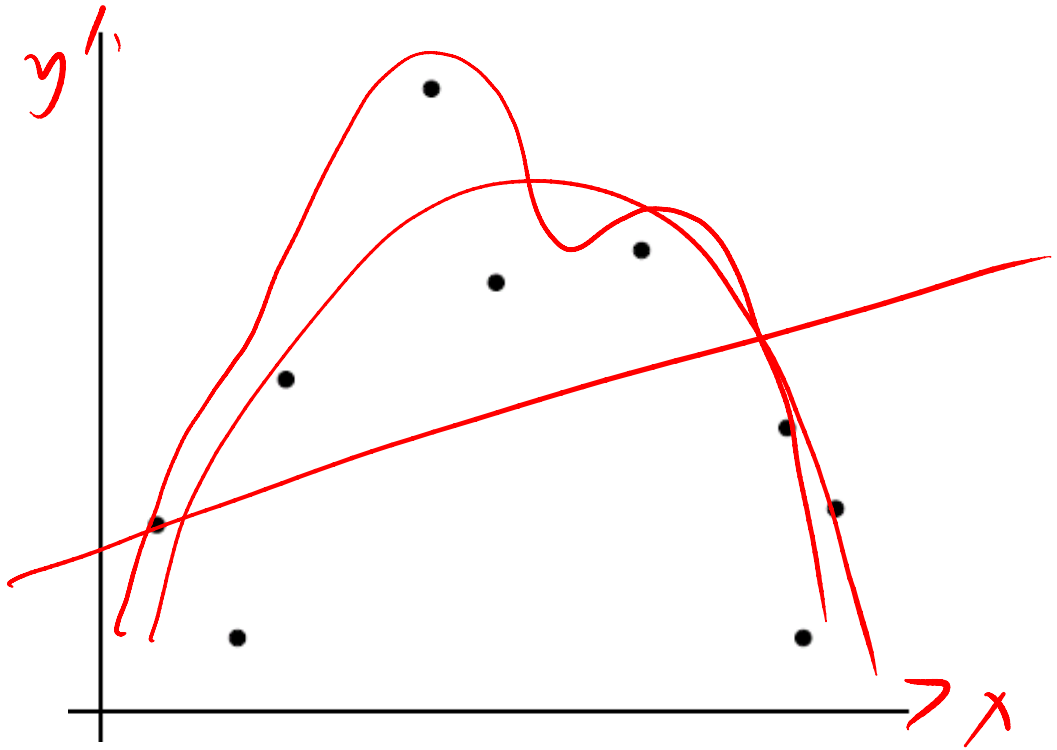
Overfitting: kNN



Another example:

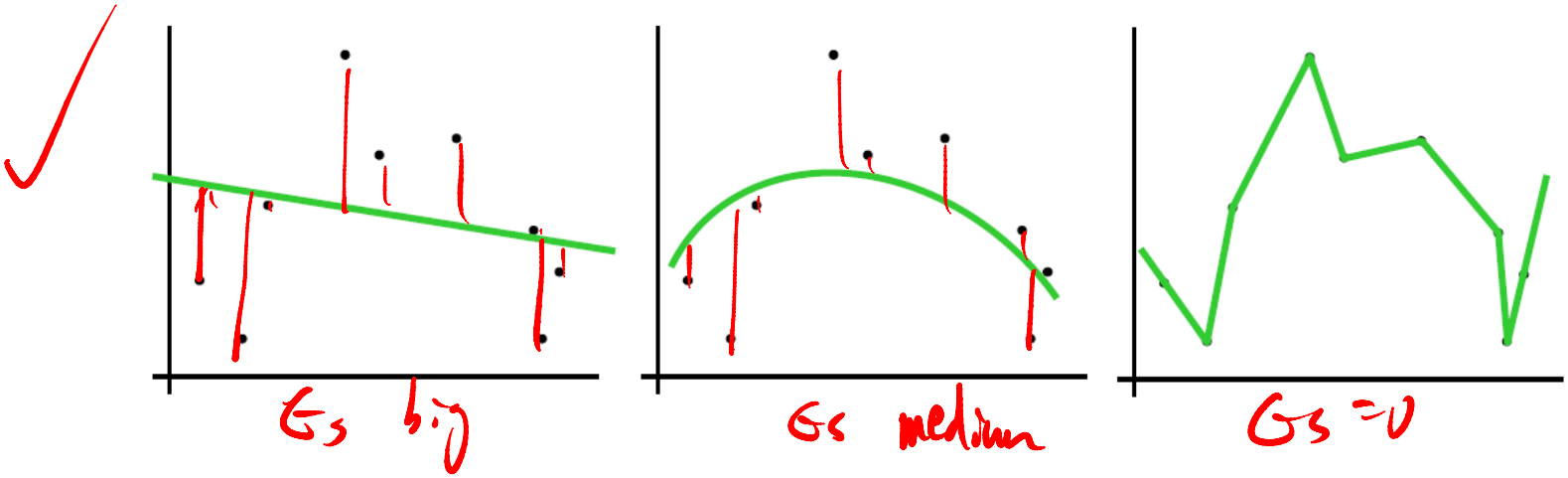


- Regression

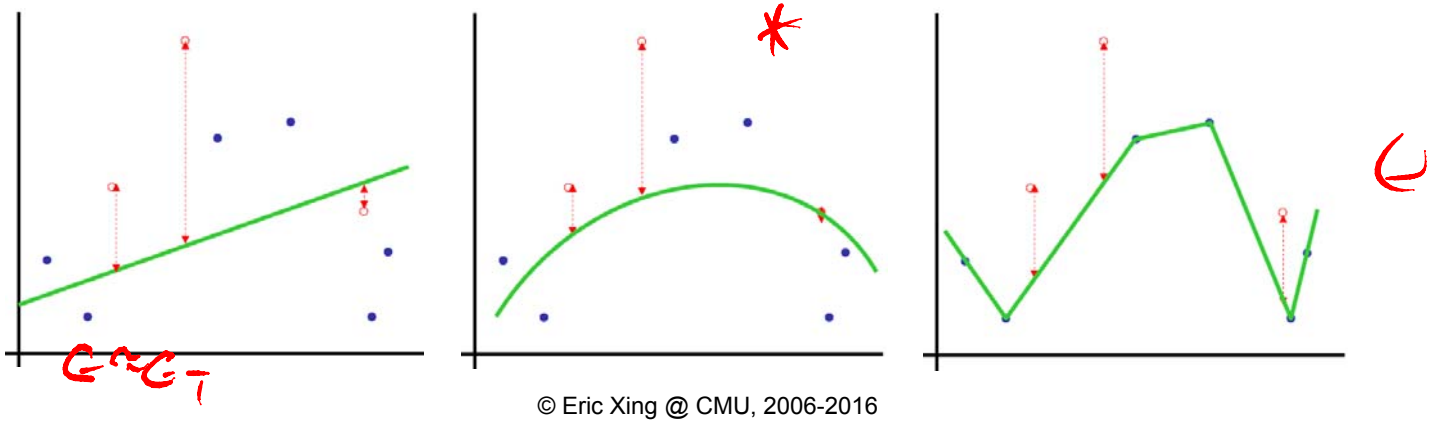


Overfitting, con'd

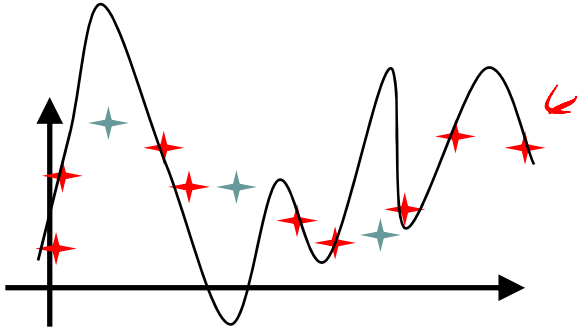
- The models:



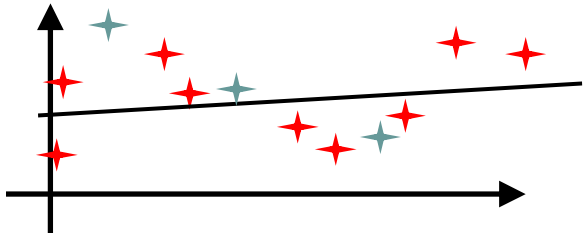
- Test errors:



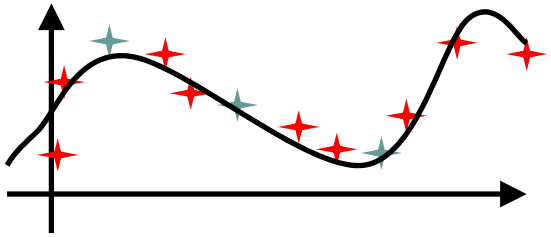
What is a good model?



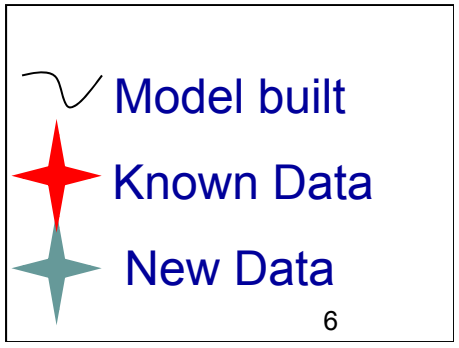
Low Robustness



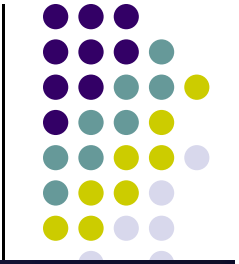
Low quality /High Robustness



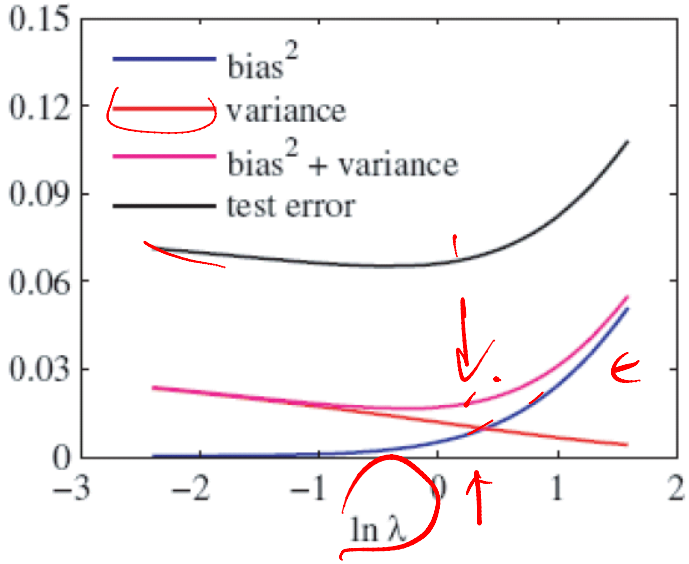
Robust Model



Bias-variance decomposition



- Now let's look more closely into two sources of errors in an functional approximator:

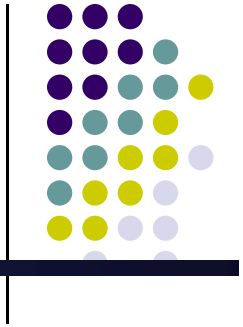


- Let $h(x) = E[t|x]$ be the **optimal** predictor, and $y(x)$ our actual predictor:

$$E_D\left[\left(y(x;D)-h(x)\right)^2\right] = \left[E_D\left[y(x;D)\right]-h(x)\right]^2 + E_D\left[\left(y(x;D)-E_D\left[y(x;D)\right]\right)^2\right]$$

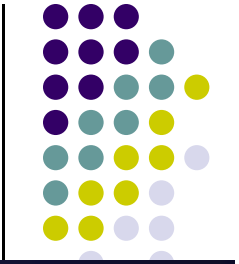
  - expected loss = (bias)² + variance + noise

Four Pillars for SLT



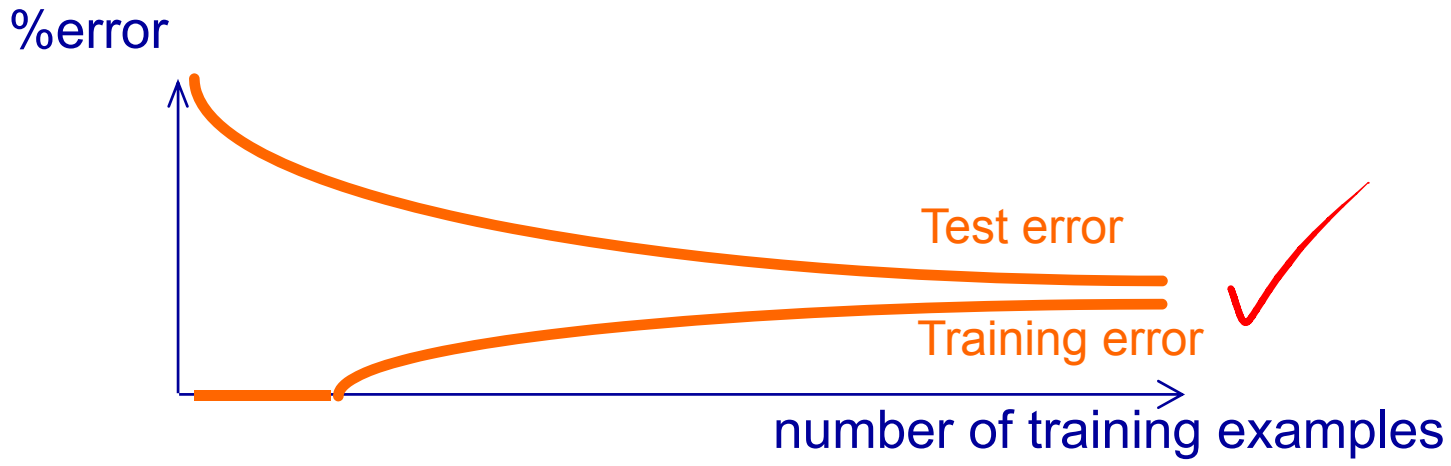
- Consistency (guarantees generalization)
  - Under what conditions will a model be consistent ?
- Model convergence speed (a measure for generalization)
  - How does generalization capacity improve when sample size *m* grows?
- Generalization capacity control
  - How to control in an efficient way model generalization starting with the only given information we have: our sample data?
- A strategy for good learning algorithms
  - Is there a strategy that guarantees, measures and controls our learning model generalization capacity ?

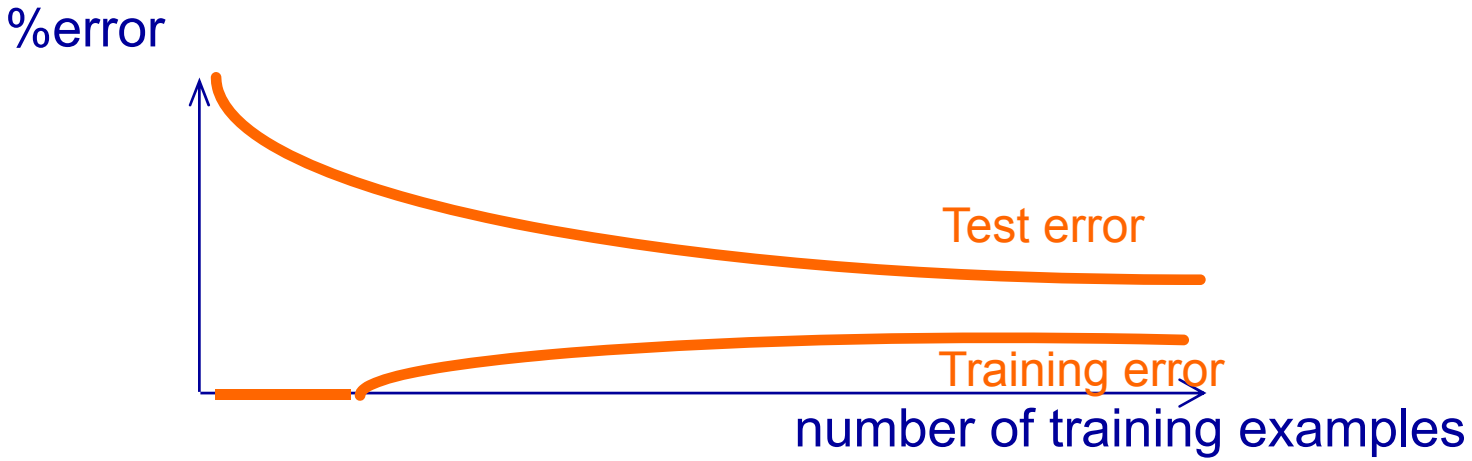
Consistency



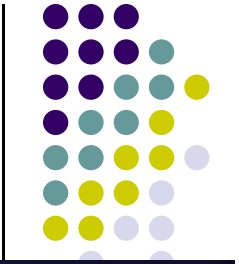
A learning process (model) is said to be consistent if model error, measured on new data sampled from the same underlying probability laws of our original sample, converges, when original sample size increases, towards model error, measured on original sample.

Consistent training?





How to control model generalization capacity

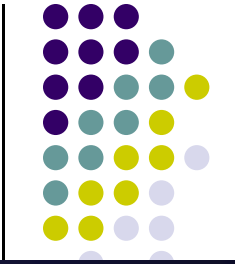


Risk Expectation = Empirical Risk + Confidence Interval

- To minimize Empirical Risk alone will not always give a good generalization capacity: one will want to minimize the sum of Empirical Risk and Confidence Interval

- What is important is not the numerical value of the Vapnik limit, most often too large to be of any practical use, it is the fact that this limit is a non decreasing function of model family function "richness"

Empirical Risk Minimization



- With probability $1-\delta$, the following inequality is true:

$$\int \left(y - f(x, w^0)\right)^2 dP(x, y) < \frac{1}{m}\sum_{i=1}^{m}\left(y_i - f(x_i, w^0)\right)^2 + \sqrt{\frac{d\left(\ln(2m/d)+1\right) - \ln\delta}{m}}$$

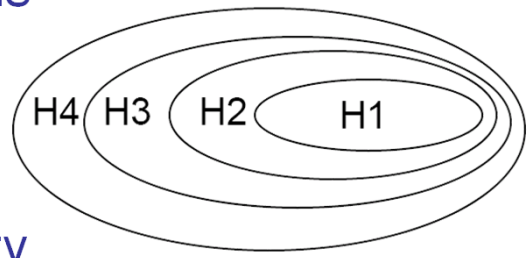
- where w^0 is the parameter w value that minimizes Empirical Risk:

$$E(W) = \frac{1}{m}\sum_{i=1}^{m}\left(y_i - f(x_i, w)\right)^2$$

Structural Risk Minimization

- Let us consider a sequence $H_1 < H_2 < .. < H_n$ of model family functions, with respective growing VC dimensions

$$d_1 < d_2 < .. < d_n$$



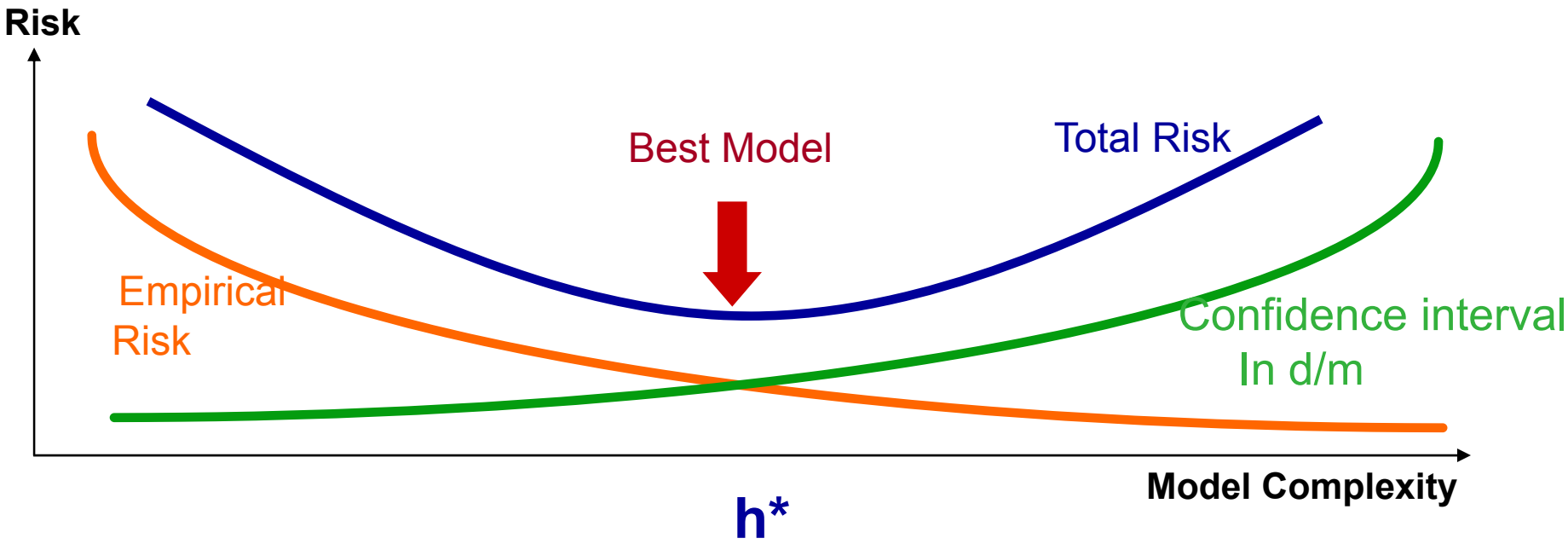
- For each family H_i of our sequence, the inequality

$$\epsilon(h) \leq \hat{\epsilon}(h) + O\left(\sqrt{\frac{d}{m}\log\frac{m}{d} - \frac{1}{m}\log\delta}\right)$$

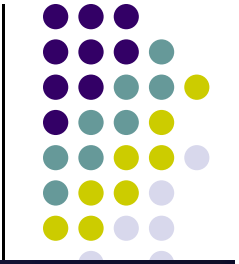
  is valid
  - That is, for each subset, we must be able either to compute *d*, or to get a bound on *d* itself.
- SRM then consists of finding that subset of functions which minimizes the bound on the actual risk.

SRM strategy

SRM : find i such that expected risk $\varepsilon(h)$ becomes minimum, for a specific $d^*=d_i$, relating to a specific family H_i of our sequence; build model using h from H_i



Putting SRM into action: linear models case (1)



- There are many SRM-based strategies to build models:

- In the case of linear models

$$y = w^T x + b,$$

one wants to make ||w|| a controlled parameter: let us call H_C the linear model function family satisfying the constraint:

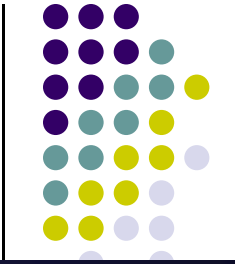
$$||w|| < C$$

Vapnik Major theorem:

When C decreases, $d(H_C)$ decreases

$||x|| < R$

Putting SRM into action: linear models case (2)



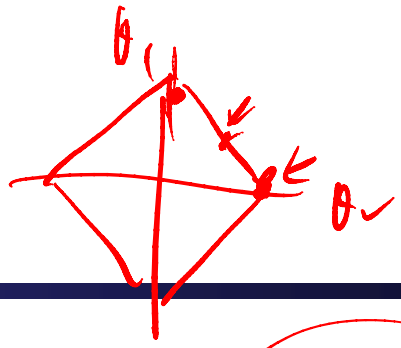
- To control ||w||, one can envision two routes to model:
  - *Regularization/Ridge Regression*, ***ie min. over w and b***

$$RG(w,b) = S\{(y_i - \langle w|x_i\rangle - b)^2 \,|i=1,..,L\} + \lambda \, ||w||^2$$

  - *Support Vector Machines (SVM)*, ***ie solve directly an optimization problem (classif. SVM, separable data)***

Minimize $||w||^2$,
with $(y_i = +/-1)$
and $y_i(\langle w|x_i\rangle + b) >= 1$ *for all* $i=1,..,L$

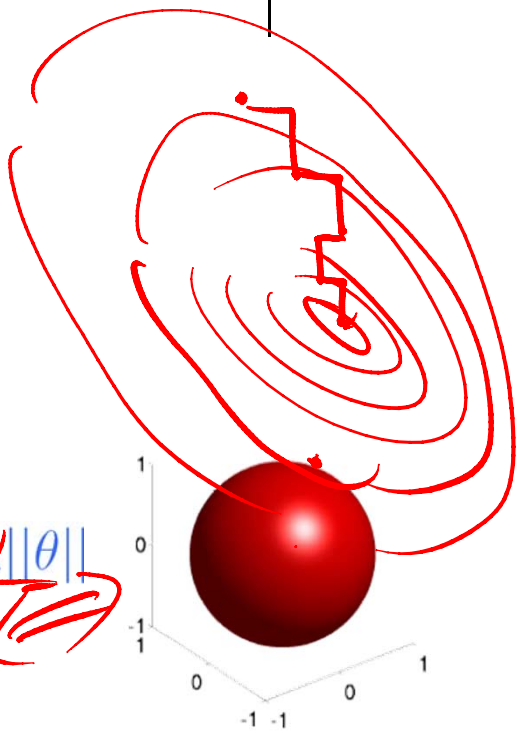
Regularized Regression



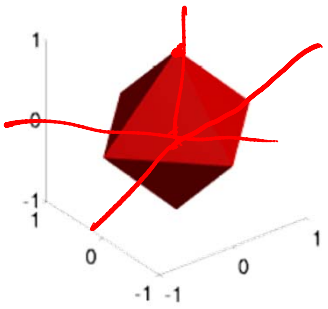
- Recall linear regression: $\mathbf{y} = \mathbf{X}^T\theta + \epsilon$

$$\begin{aligned}\theta^* &= \arg\max_\theta (\mathbf{y} - \mathbf{X}^T\theta)^T(\mathbf{y} - \mathbf{X}^T\theta) \\ &= \arg\max_\theta ||\mathbf{y} - \mathbf{X}^T\theta||^2\end{aligned}$$

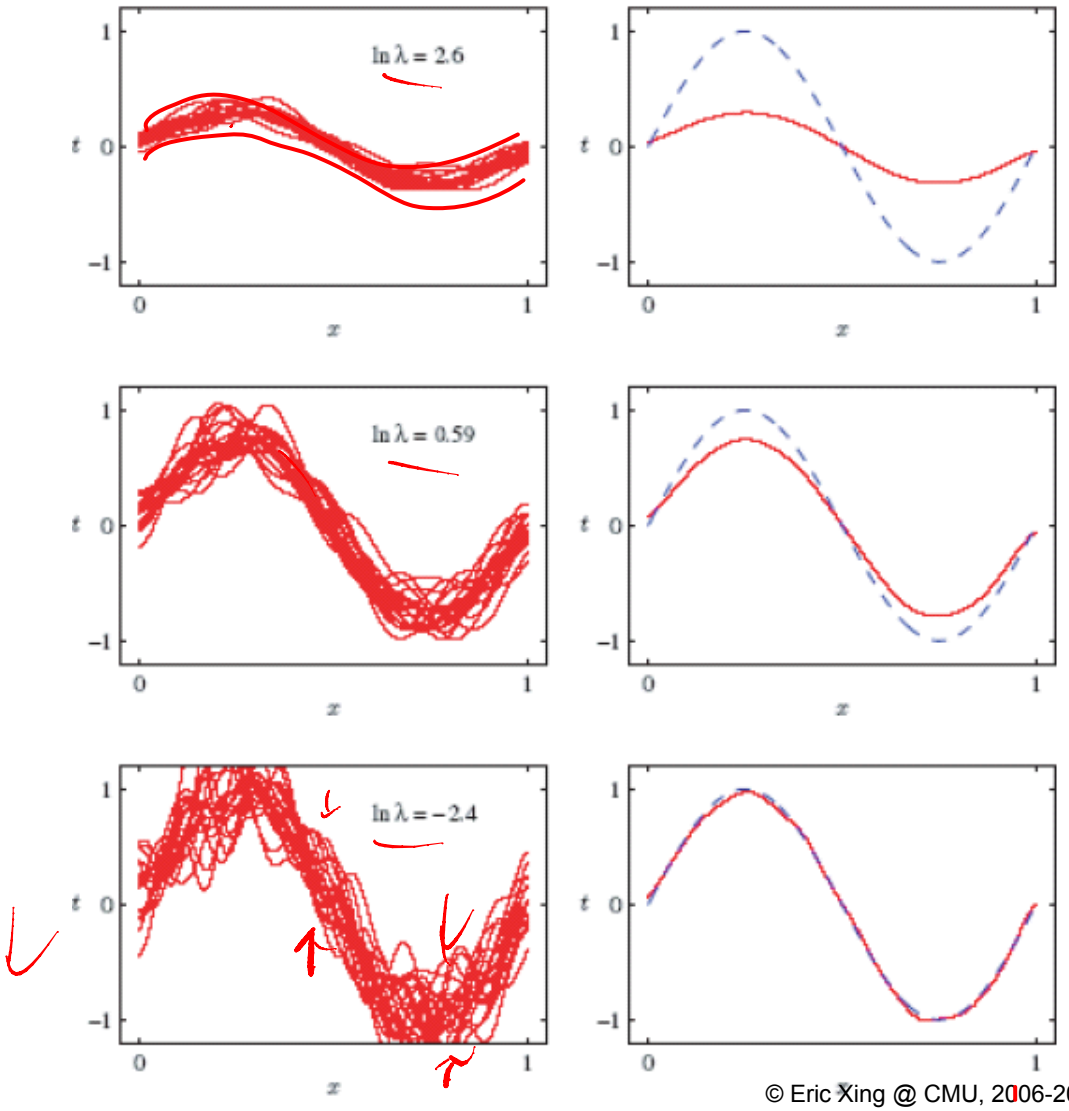
- Regularized LR:
  - L2-regularized LR: $\theta^* = \arg\max_\theta ||\mathbf{y} - \mathbf{X}^T\theta||^2 + \lambda||\theta||$



  - L1-regularized LR: $\theta^* = \arg\max_\theta ||\mathbf{y} - \mathbf{X}^T\theta||^2 + \lambda|\theta|$

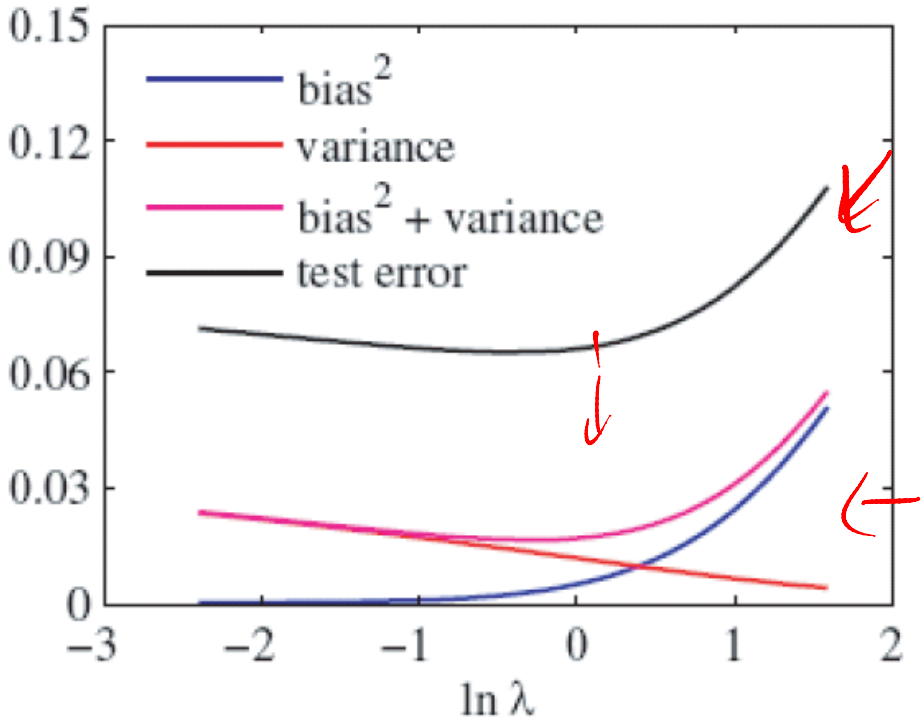


Bias-variance tradeoff



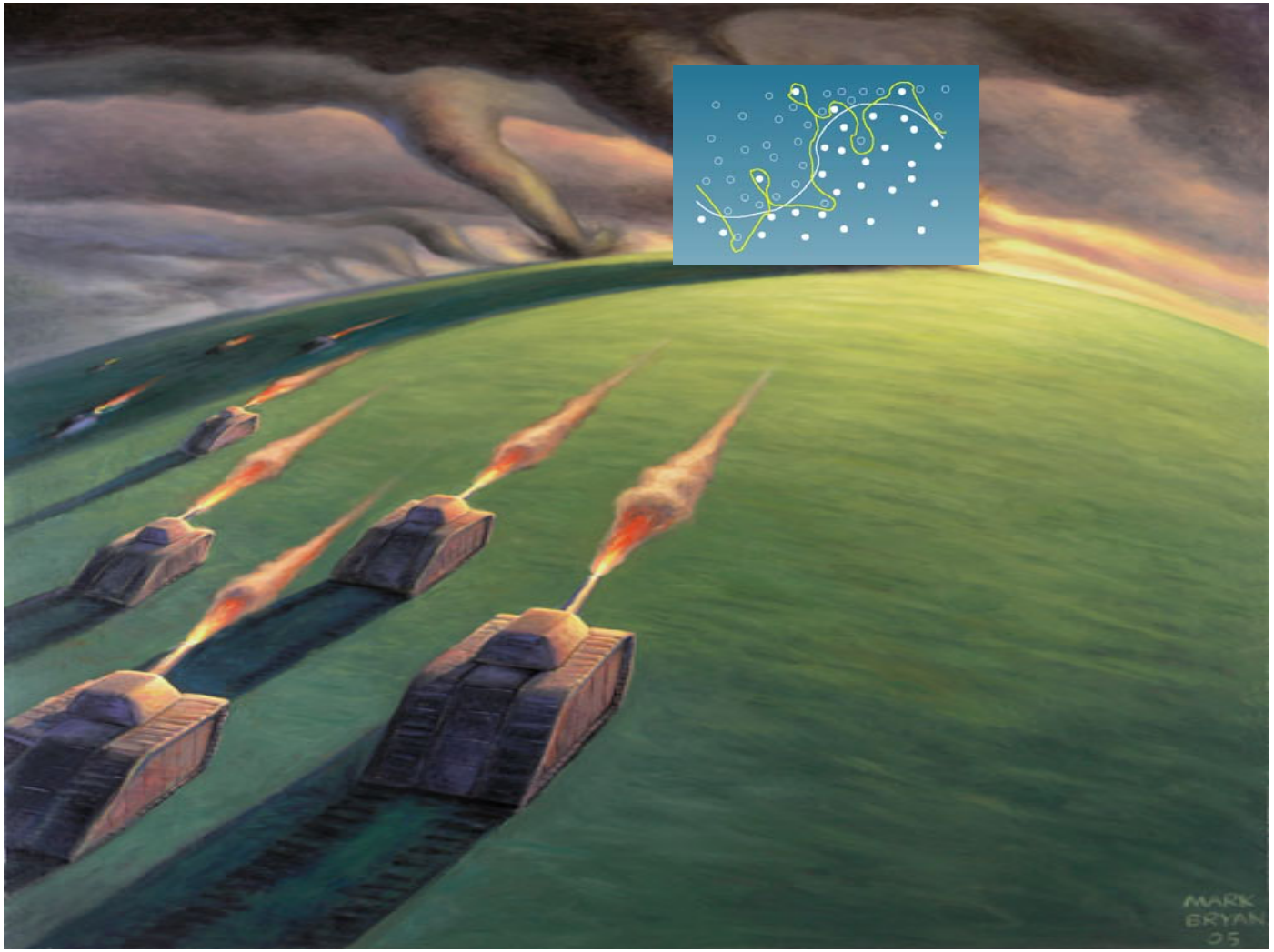
- λ is a "regularization" terms in LR, the smaller the λ, is more complex the model (why?)
  - Simple (highly regularized) models have low variance but high bias.
  - Complex models have low bias but high variance.
- You are inspecting an empirical average over 100 training set.
- The actual E_D can not be computed

Bias^2+variance vs regularizer

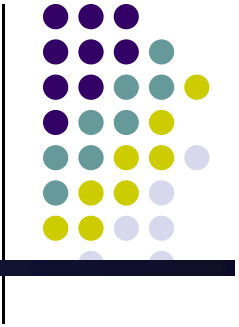


- Bias^2+variance predicts (shape of) test error quite well.
- However, bias and variance cannot be computed since it relies on knowing the true distribution of x and t (and hence $h(x) = E[t|x]$).

The battle against overfitting



Model Selection



- Suppose we are trying select among several different models for a learning problem.
- Examples:
  - 1. polynomial regression

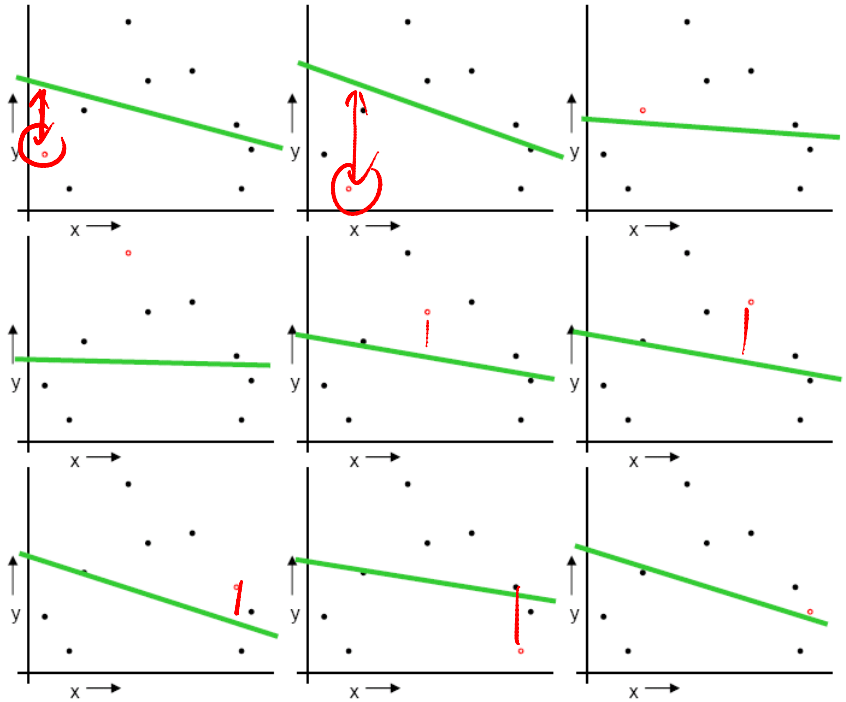
$$h(x;\theta) = g(\theta_0 + \theta_1 x + \theta_2 x^2 + \ldots + \theta_k x^k)$$

    - Model selection: we wish to **automatically** and **objectively** decide if k should be, say, 0, 1, . . . , or 10.
  - 2. locally weighted regression,
    - Model selection: we want to automatically choose the bandwidth parameter τ.
  - 3. Mixture models and hidden Markov model,
    - Model selection: we want to decide the number of hidden states
- The Problem:
  - Given model family $\mathcal{F} = \{M_1, M_2, \ldots, M_I\}$, find $M_i \in \mathcal{F}$ s.t.

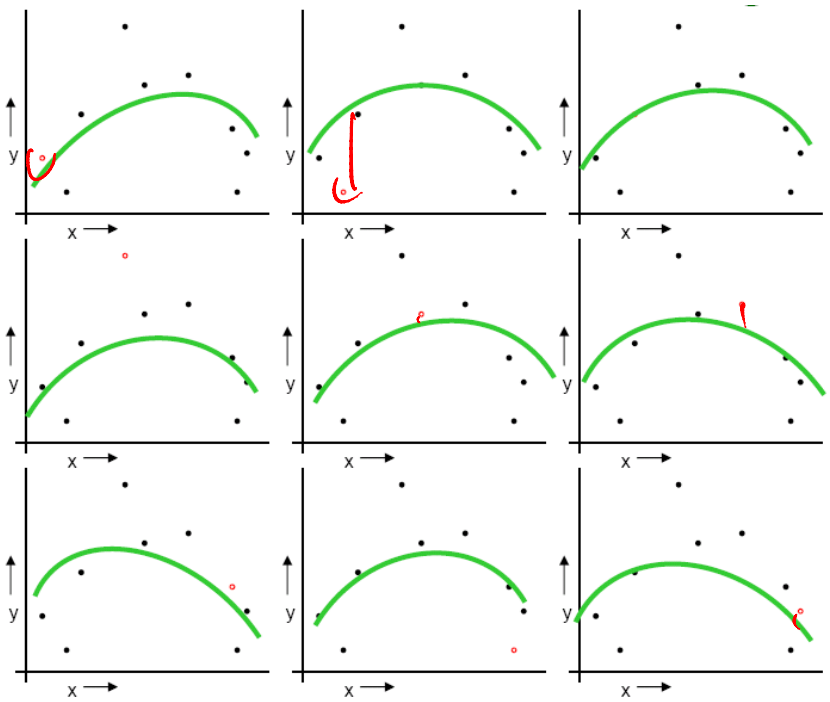
$$M_i = \arg\max_{M \in \mathcal{F}} J(D, M)$$

1. Cross Validation
Example:

- When $\alpha=1/N$, the algorithm is known as Leave-One-Out-Cross-Validation (LOOCV)

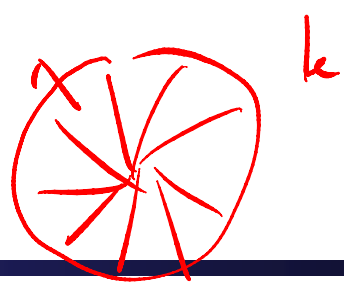


$MSELOOCV(M_1)=2.12$



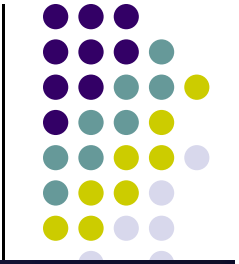
$MSELOOCV(M_2)=0.962$

1. Cross Validation



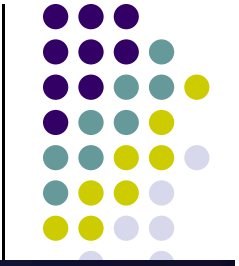
- We are given training data D and test data D_{test}, and we would like to fit this data with a model $p_i(x;\theta)$ from the family $\mathcal{F}$ (e.g, an LR), which is indexed by i and parameterized by θ.
- K-fold cross-validation (CV)
  - Set aside αN samples of D (where $N = |D|$). This is known as the held-out data and will be used to evaluate different values of i.
  - For each candidate model i, fit the optimal hypothesis $p_i(x;\theta^*)$ to the remaining $(1-\alpha)N$ samples in D (i.e., hold i fixed and find the best θ).
  - Evaluate each model $p_i(x|\theta*)$ on the held-out data using some pre-specified risk function.
  - Repeat the above ***K* times**, choosing a **different** held-out data set each time, and the scores are averaged for each model $p_i(.)$ over all held-out data set. This gives an estimate of the risk curve of models over different i.
  - For the model with the lowest risk, say $p_{i*}(.)$, we use all of D to find the parameter values for $p_{i*}(\mathrm{x};\theta^*)$.

Practical issues for CV



- How to decide the values for K and α
  - Commonly used K = 10 and α = 0.1.
  - when data sets are small relative to the number of models that are being evaluated, we need to decrease α and increase K
  - K needs to be large for the variance to be small enough, but this makes it time-consuming.
- Bias-variance trade-off
  - Small α usually lead to low bias. In principle, *LOOCV* provides an almost unbiased estimate of the generalization ability of a classifier, especially when the number of the available training samples is severely limited; but it can also have high variance.
  - Large α can reduce variance, but will lead to under-use of data, and causing high-bias.
- One important point is that the test data D_{test} is never used in CV, because doing so would result in overly (indeed dishonest) optimistic accuracy rates during the testing phase.

2. Regularization



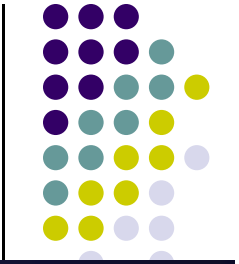
- Maximum-likelihood estimates are not always the best (James and Stein showed a counter example in the early 60's)
- Alternative: we "regularize" the likelihood objective (also known as penalized likelihood, shrinkage, smoothing, etc.), by adding to it a penalty term:

$$\hat{\theta}_{\text{shrinkage}} = \arg\max_{\theta}\left[l(\theta; D) + \lambda\|\theta\|\right]$$

where λ>0 and $||\theta||$ might be the L_1 or L_2 norm.

- The choice of norm has an effect
  - using the L_2 norm pulls directly towards the origin,
  - while using the L1 norm pulls towards the coordinate axes, i.e it tries to set some of the coordinates to 0.
  - This second approach can be useful in a feature-selection setting.

Recall Bayesian and Frequentist



- Frequentist interpretation of probability
  - Probabilities are objective properties of the real world, and refer to limiting relative frequencies (e.g., number of times I have observed heads). Hence one cannot write P(Katrina could have been prevented|D), since the event will never repeat.
  - Parameters of models are *fixed, unknown constants*. Hence one cannot write $P(\theta|D)$ since θ does not have a probability distribution. Instead one can only write $P(D|\theta)$.
  - One computes point estimates of parameters using various *estimators*, $\theta^* = f(D)$, which are designed to have various desirable qualities when *averaged over future data D* (assumed to be drawn from the "true" distribution).
- Bayesian interpretation of probability
  - Probability describes degrees of belief, not limiting frequencies.
  - Parameters of models are *hidden variables*, so one can compute $P(\theta|D)$ or $P(f(\theta)|D)$ for some function f.
  - One estimates parameters by computing $P(\theta|D)$ using Bayes rule:

$$p(\theta|D) = \frac{p(D \mid \theta)\, p(\theta)}{p(D)}$$

Bayesian interpretation of regulation

- Regularized Linear Regression
  - Recall that using squared error as the cost function results in the LMS estimate
  - And assume iid data and Gaussian noise, LMS is equivalent to MLE of θ

$$l(\theta) = n \log \frac{1}{\sqrt{2\pi}\sigma} - \frac{1}{\sigma^2}\frac{1}{2}\sum_{i=1}^{n}(y_i - \theta^T \mathbf{x}_i)^2$$

  - Now assume that vector θ follows a normal prior with 0-mean and a diagonal covariance matrix

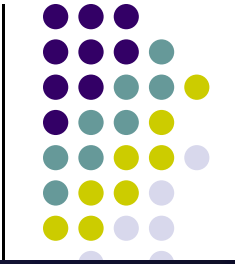
$$\theta \sim N(0, \tau^2 I)$$

  - What is the posterior distribution of θ?

$$p(\theta|D) \propto p(D,\theta)$$

$$= p(D|\theta)\,p(\theta) = \left(2\pi\sigma^2\right)^{-n/2} \exp\left\{-\frac{1}{2\sigma^2}\sum_{i=1}^{n}\left(y_n - \theta^T x_i\right)^2\right\} \times C \exp\left\{-(\theta^T\theta/2\tau^2\right\}$$

Bayesian interpretation of regulation, con'd



- The posterior distribution of θ

$$p(\theta|D) \propto \exp\left\{-\frac{1}{2\sigma^2}\sum_{i=1}^{n}\left(y_n-\theta^T x_i\right)^2\right\}\times\exp\left\{-\theta^T\theta/2\tau^2\right\}$$

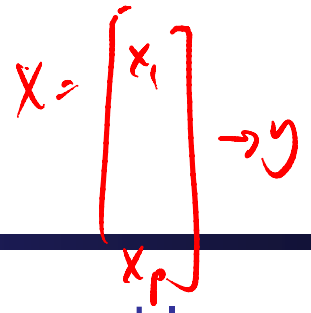
- This leads to a now objective

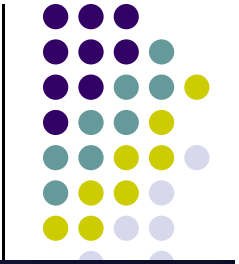
$$l_{MAP}(\theta;D) = -\frac{1}{2\sigma^2}\frac{1}{2}\sum_{i=1}^{n}(y_i-\theta^T\mathbf{x}_i)^2 - \frac{1}{\tau^2}\frac{1}{2}\sum_{k=1}^{K}\theta_k^2$$
$$= l(\theta;D) + \lambda\|\theta\|$$

  - This is L_2 regularized LR! --- a MAP estimation of θ
  - What about L_1 regularized LR! (homework)

- How to choose λ
  - cross-validation!

3. Feature Selection





- Imagine that you have a supervised learning problem where the number of features d is very large (perhaps d >>#samples), but you suspect that there is only a small number of features that are "**relevant**" to the learning task.

- VC-theory can tell you that this scenario is likely to lead to high generalization error – the learned model will potentially overfit unless the training set is fairly large.

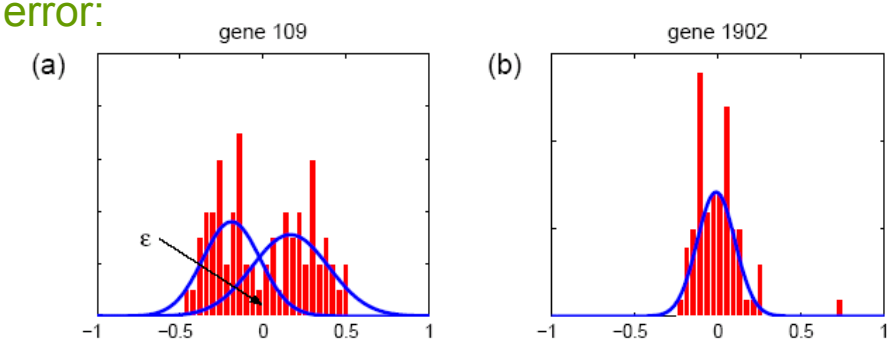
- So lets get rid of useless parameters!

How to score features

- How do you know which features can be pruned?
  - Given labeled data, we can compute some simple score $S(i)$ that measures how informative each feature x_i is about the class labels y.
  - Ranking criteria:
    - Mutual Information: score each feature by its mutual information with respect to the class labels

$$MI(x_i, y) = \sum_{x_i \in \{0,1\}} \sum_{y \in \{0,1\}} p(x_i, y) \log \frac{p(x_i, y)}{p(x_i)\, p(y)}$$

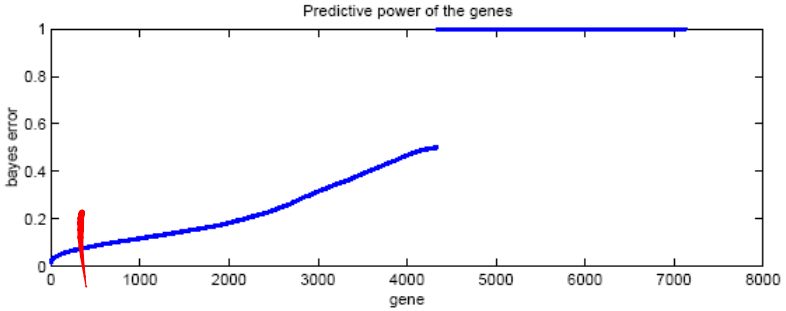
    - Bayes error:



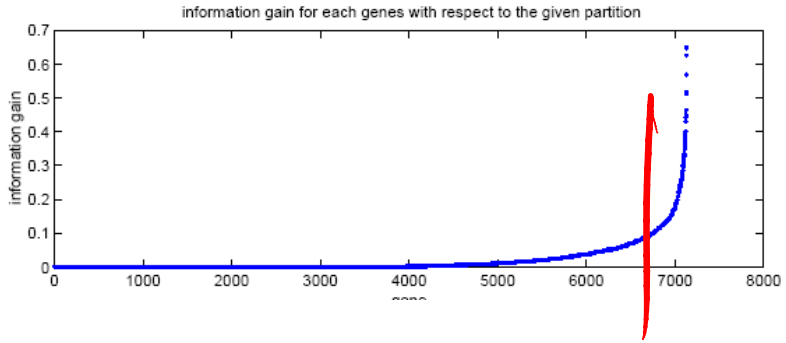
    - Redundancy (Markov-blank score) …
  - We need estimate the relevant p()'s from data, e.g., using MLE

Feature Ranking

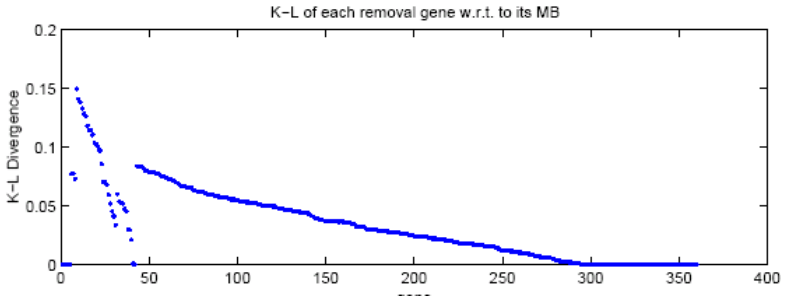
- Bayes error of each gene



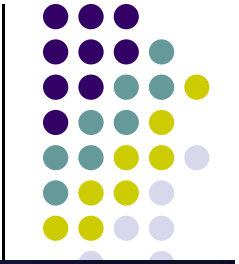
- information gain for each genes with respect to the given partition



- KL of each removal gene w.r.t. to its MB

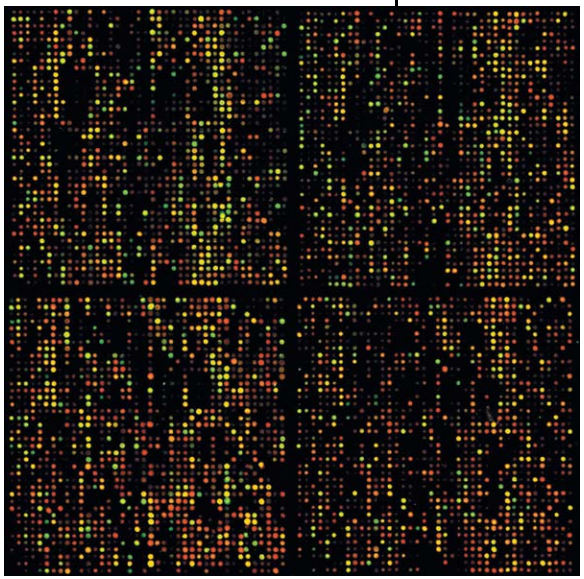


Feature selection schemes

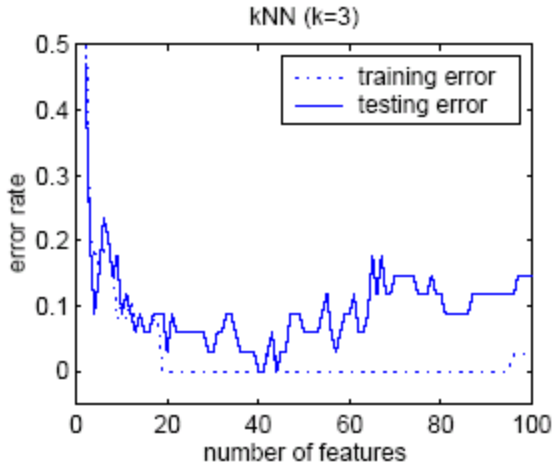


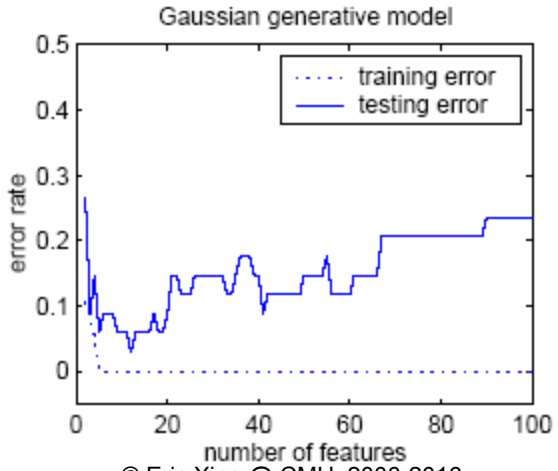
- Given n features, there are 2^n possible feature subsets (why?)
- Thus feature selection can be posed as a model selection problem over 2^n possible models.
- For large values of n, it's usually too expensive to explicitly enumerate over and compare all 2^n models. Some heuristic search procedure is used to find a good feature subset.
- Three general approaches:
  - Filter: i.e., direct feature ranking, but taking no consideration of the subsequent learning algorithm
    - add (from empty set) or remove (from the full set) features one by one based on $S(i)$
    - Cheap, but is subject to local optimality and may be unrobust under different classifiers
  - Wrapper: determine the (inclusion or removal of) features based on performance under the learning algorithms to be used. See next slide
  - Simultaneous learning and feature selection.
    - E.x. L_1 regularized LR, Bayesian feature selection (will not cover in this class), etc.

Case study [Xing et al, 2001]

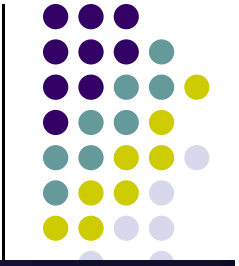


- The case:
  - 7130 genes from a microarray dataset
  - 72 samples
  - 47 type I Leukemias (called ALL)
    and 25 type II Leukemias (called AML)
- Three classifier:
  - kNN
  - Gaussian classifier
  - Logistic regression



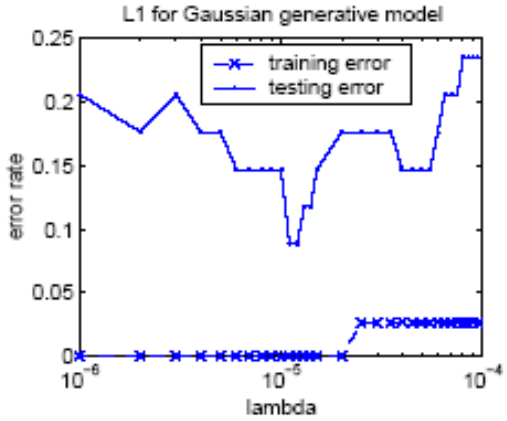


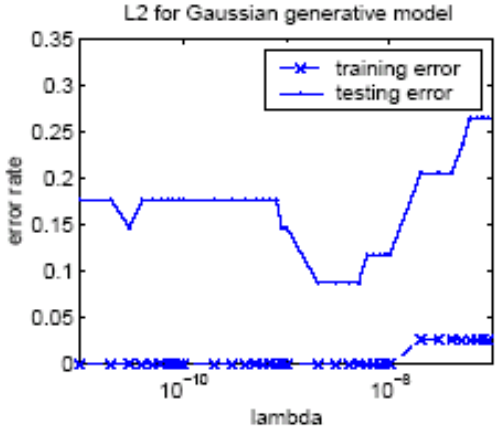
Regularization vs. Feature Selection



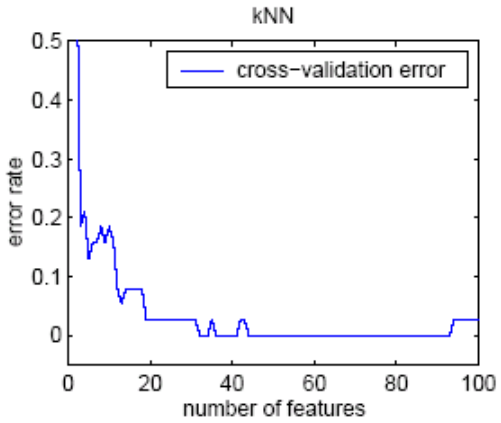
- Explicit feature selection often outperform regularization

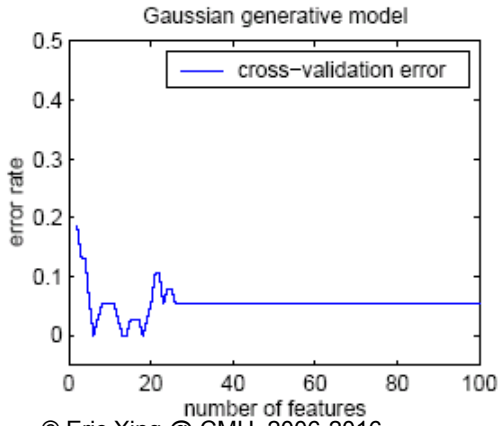
regression

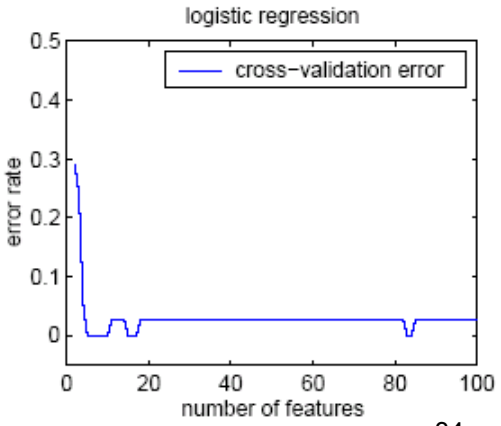




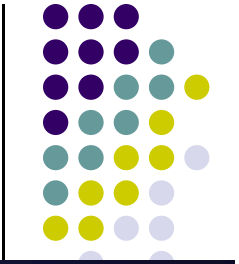
Feature Selection







4. Information criterion



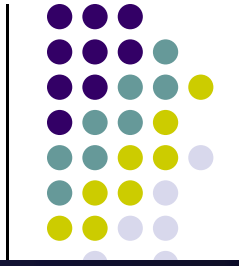
- Suppose we are trying select among several different models for a learning problem.

- The Problem:
  - Given model family $\mathcal{F} = \{M_1, M_2, \ldots, M_I\}$, find $M_i \in \mathcal{F}$ s.t.

$$M_i = \arg\max_{M \in \mathcal{F}} J(D, M)$$

- We can design J that not only reflect the predictive loss, but also the amount of information M_k can hold

Model Selection via Information Criteria

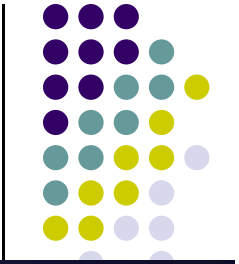


- Let $f(x)$ denote the truth, the underlying distribution of the data
- Let $g(x,\theta)$ denote the model family we are evaluating
  - $f(x)$ does not necessarily reside in the model family
  - $\theta_{\text{ML}}(y)$ denote the MLE of model parameter from data y
- Among early attempts to move beyond Fisher's *Maliximum Likelihood* framework, **Akaike** proposed the following information criterion:

$$E_y\left[D\left(f \,\|\, g(x \mid \theta_{ML}(y))\right)\right]$$

which is, of course, intractable (because $f(x)$ is unknown)

AIC and TIC



- AIC (An information criterion, not **Akaike** information criterion)

$$A = \log g(x \mid \hat{\theta}(y)) - k$$

where k is the number of parameters in the model

- TIC (Takeuchi information criterion)

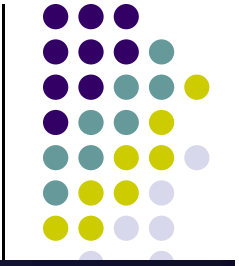
$$A = \log g(x \mid \hat{\theta}(y)) - \mathrm{tr}(I(\theta_0)\Sigma)$$

where

$$\theta_0 = \arg\min D(f \,\|\, g(\cdot \mid \theta)) \qquad I(\theta_0) = -E_x\left[\frac{\partial^2 \log g(x \mid \theta)}{\partial\theta\partial\theta^T}\right]\Bigg|_{\theta=\theta_0} \qquad \Sigma = E_y\left(\hat{\theta}(y) - \theta_0\right)\left(\hat{\theta}(y) - \theta_0\right)^T$$

  - We can approximate these terms in various ways (e.g., using the bootstrap)
  - $\mathrm{tr}(I(\theta_0)\Sigma) \approx k$

5. Bayesian Model Averaging



- Recall the Bayesian Theory: (e.g., for date *D* and model *M*)

$$P(M|D) = P(D|M)P(M)/P(D)$$

  - the **posterior** equals to the **likelihood** times the **prior**, up to a constant.

- Assume that $P(M)$ is uniform and notice that $P(D)$ is constant, we have the following criteria:

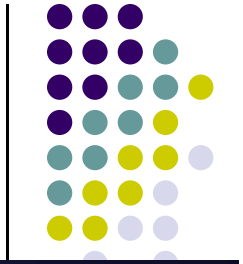
$$P(D \mid M) = \int_{\theta} P(D \mid \theta, M) P(\theta \mid M) d\theta$$

- A few steps of approximations (you will see this in advanced ML class in later semesters) give you this:

$$P(D \mid M) \approx \log P(D \mid \hat{\theta}_{ML}) - \frac{k}{2} \log N$$

where N is the number of data points in D.

Summary



- Structural risk minimization
- Bias-variance decomposition
- The battle against overfitting:
  - Cross validation
  - Regularization
  - Feature selection
  - Model selection --- Occam's razor
  - Model averaging
    - The Bayesian-frequentist debate
    - Bayesian learning (weight models by their posterior probabilities)